orm PTO-1449

Applicant: Serial No.: Fling Date: David Y. Kao, et al. 08/720,693

October 20, 1996



Sheet 1 of 2

Att'y Docket No. 11675.107

Group: 1109

For:

OXIDATION OFIONIMPLANTED SEMICONDUCTORS

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GROUP 1100

U.S. Patent Documents

| Examiner <u>Initial*</u> | Patent Number | Issue <u>Date</u> | <u>Name</u> | Class | Sub <u>Class</u> | Filing Date |
|-----------------------------|------------------|----------------------|---------------|-----------------|---------------------|----------------|
| | 4,683,645 | 08/04/87 | Naguib et al. | -437 | -41 | 12/24/85 |
| A2 | 5,358,894 | 10/25/94 | Fazan et al. | -437 | -70 - | 12/30/93 |

Foreign Patent Documents

| Examiner | Document | Publ. | Country or | Sub | | Trans- | |
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| Initial* | Number | Date | Patent Office | Class | <u>Class</u> | lation | |

NONE

Other Documents

(including author (if listed), title, relevant pages, date of publication including at least month and year).

Examiner

Initial*

NONE

Examiner:

FOURSON

Date Considered:

9/23/97

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Sheet 2 of 2

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References Cited by Applicants

While the filing of Information Disclosure Statements is voluntary, the procedure is governed by the guidelines of Section 609 of the Manual of Patent Examining Procedure and 37 C.F.R. §§ 1.97 and 1.98. To be considered a proper Information Disclosure Statement, Form PTO-1449 shall be accompanied by a copy of each listed patent or publication or other item of information and a translation of the pertinent portions of foreign documents (if an existing translation is readily available to the applicant), an explanation of relevance of each reference not in the English language, and should be submitted in a timely manner as set out in MPEP Sec. 609.

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Each citation initialed by the Examiner will be printed on the issued patent in the same manner as references cited by the Examiner on Form PTO-892.

The reference designations "A1," "A2," etc. (referring to Applicant's reference 1, Applicant's reference 2, etc.) will be used by the Examiner in the same manner as Examiner's reference designations "A," "B," "C," etc. on Office Action Form PTO-1142.

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